

**Notice of References Cited**

Application/Control No.

10/760,009

Applicant(s)/Patent Under  
Reexamination  
TUIJN ET AL.

Examiner

Chad Dickerson

Art Unit

2625

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,411,314	06-2002	Hansen et al.	715/769
*	B	US-2002/0071134	06-2002	Jackson et al.	358/1.13
*	C	US-7,016,068	03-2006	Gnocato et al.	358/1.18
*	D	US-2002/0178044	11-2002	Bicknell et al.	705/9
*	E	US-5,479,343	12-1995	Matoba et al.	700/106
*	F	US-7,003,723	02-2006	Kremer et al.	715/517
*	G	US-6,441,920	08-2002	Smith, David D.	358/1.2
*	H	US-5,634,091	05-1997	Sands et al.	358/1.18
*	I	US-2002/0145750	10-2002	Honda et al.	358/1.15
*	J	US-2002/0188597	12-2002	Kern et al.	707/1
*	K	US-2002/0078432	06-2002	Charisius et al.	717/102
*	L	US-2004/0061891	04-2004	Philpot, Paul	358/001.15
*	M	US-6,278,901	08-2001	Winner et al.	700/99

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.